

Search Notes**Application/Control No.**

10/602,302

Examiner

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Applicant(s)/Patent under Reexamination

MEAD ET AL.

Art Unit

3751

SEARCHED

Class	Subclass	Date	Examiner
401	137-140, 25,130, 266	5/14/2006	HK
15	230.11	5/14/2006	HK
15	244.1	5/14/2006	HK
15	244.2	5/14/2006	HK
492	13,19,28	5/14/2006	HK
492	30	5/14/2006	HK

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
interference search, see print out	5/15/2006	HK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner